## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHANG ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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## **NON-PATENT DOCUMENTS**

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	υ	Asawa "Measuring and Analyzing Service Levels: A Scalable Passive Approach", 12/1998, Hewlett-Packard Labatories, Pages 3-12.						
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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